



#### **60V P-CHANNEL ENHANCEMENT MODE MOSFET**

### **Product Summary**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub> max	I <sub>D</sub> max T <sub>A</sub> = +25°C		
-60V	110mΩ @ V <sub>GS</sub> = -10V	-4.5A		
	130mΩ @ V <sub>GS</sub> = -4.5V	-4.2A		

### **Description and Applications**

This MOSFET has been designed to minimize the on-state resistance  $(R_{DS(ON)})$  and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Backlighting
- Power Management Functions
- DC-DC Converters

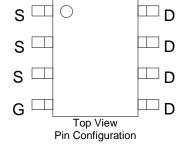
### **Features and Benefits**

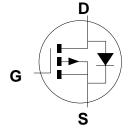
- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- · Fast Switching Speed
- Low Input/ Output Leakage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability
- PPAP Capable (Note 4)

#### **Mechanical Data**

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
   UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Lead Frame. Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.072g (Approximate)







**Equivalent Circuit** 

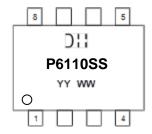
Ordering Information (Note 5)

Part Number	Case	Packaging
DMP6110SSSQ-13	SO-8	2500/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. Automotive products are AEC-Q101 qualified and are PPAP capable. Refer to http://www.diodes.com/product\_compliance\_definitions.html.
- 5. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

## **Marking Information**



| = Manufacturer's Marking
 P6110SS = Product Type Marking Code
 YYWW = Date Code Marking
 YY = Year Code (ex: 14 = 2014)
 WW = Week Code (01 to 53)



# 

Characteristic		Symbol	Value	Unit
Drain-Source Voltage		V <sub>DSS</sub>	-60	V
Gate-Source Voltage	V <sub>GSS</sub>	±20	V	
Drain Current (Note 7) V <sub>GS</sub> = -10V t < 10s	$T_A = +25$ °C $T_A = +70$ °C	I <sub>D</sub>	-4.5 -3.6	А
Maximum Body Diode Forward Current (Note 7)	I <sub>S</sub>	-2.1	A	
Pulsed Drain Current (10μs Pulse, Duty Cycle = 1%)	I <sub>DM</sub>	-19	A	
Avalanche Current (Note 8) L = 0.1mH	I <sub>AS</sub>	-17.6	A	
Avalanche Energy (Note 8) L = 0.1mH	E <sub>AS</sub>	15.4	mJ	

## Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 6)		P <sub>D</sub>	1.5	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	C	80	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{ heta JA}$	48	°C/W
Total Power Dissipation (Note 7)		P <sub>D</sub>	2.0	W
Thermal Resistance, Junction to Ambient (Note 7)	Steady State	D	61	°C/W
Thermal Resistance, Junction to Ambient (Note 7)	t<10s	$R_{\theta JA}$	37	°C/W
Thermal Resistance, Junction to Case	$R_{ heta JC}$	6.4	°C/W	
Operating and Storage Temperature Range		$T_{J,}T_{STG}$	-55 to +150	°C

## **Electrical Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 9)						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-60	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	-1	μA	V <sub>DS</sub> = -48V, V <sub>GS</sub> = 0V
Gate-Source Leakage	I <sub>GSS</sub>	_	_	100	nA	$V_{GS} = \pm 16V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 9)			•		•	
Gate Threshold Voltage	$V_{GS(TH)}$	-1	_	-3	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
Static Drain-Source On-Resistance	D	_	86	110	mΩ	$V_{GS} = -10V, I_D = -4.5A$
Static Dialif-Source Off-Resistance	R <sub>DS(ON)</sub>	_	98	130		$V_{GS} = -4.5V, I_{D} = -3.5A$
Diode Forward Voltage	V <sub>SD</sub>	_	-0.7	-1.2	V	$V_{GS} = 0V, I_{S} = -1A$
DYNAMIC CHARACTERISTICS (Note 10)						
Input Capacitance	Ciss	_	1030	_		
Output Capacitance	Coss	_	49.1	_	pF	$V_{DS} = -30V$ , $V_{GS} = 0V$ , $f = 1.0MHz$
Reverse Transfer Capacitance	C <sub>rss</sub>	_	38.7	_		
Gate Resistance	$R_G$	_	13.6	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (V <sub>GS</sub> = -4.5V)	Qg	_	9.5	_		
Total Gate Charge (V <sub>GS</sub> = -10V)	Qg	_	19.4	_	nC	$V_{DS} = -30V, I_{D} = -5A$
Gate-Source Charge	$Q_{gs}$	_	2.3	_	nc nc	VDS = -30V, ID = -3A
Gate-Drain Charge	Q <sub>gd</sub>	_	3.6	_		
Turn-On Delay Time	t <sub>D(ON)</sub>	_	3.7	_		
Turn-On Rise Time	t <sub>R</sub>	_	6.3	_	ns	$V_{GS} = -10V$ , $V_{DS} = -30V$ , $R_{GEN} = 6\Omega$ ,
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	58.7	_	115	$I_D = -5A$
Turn-Off Fall Time	t <sub>F</sub>	_	26.1	_		
Body Diode Reverse Recovery Time	t <sub>RR</sub>		14.85		ns	$I_S = -5A$ , $dI/dt = 100A/\mu s$
Body Diode Reverse Recovery Charge	Q <sub>RR</sub>		8.8		nC	$I_S = -5A$ , $dI/dt = 100A/\mu s$

6. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

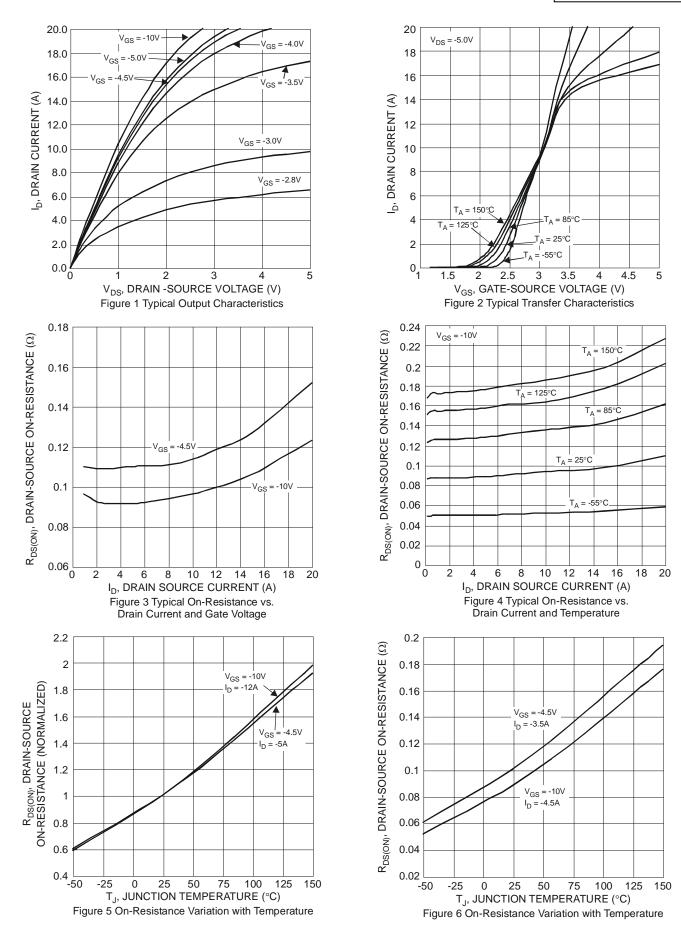
7. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

8. UIS in production with L = 0.1mH, starting T<sub>A</sub> = +25°C.

9. Short duration pulse test used to minimize self-heating effect.

10. Guaranteed by design. Not subject to product testing. Notes:







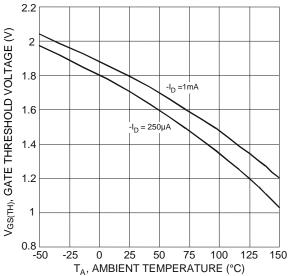
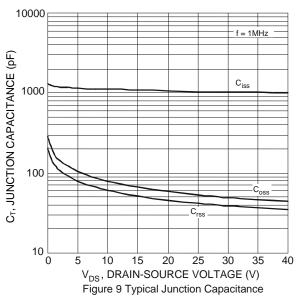
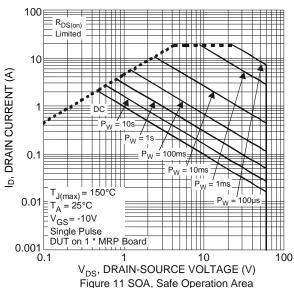
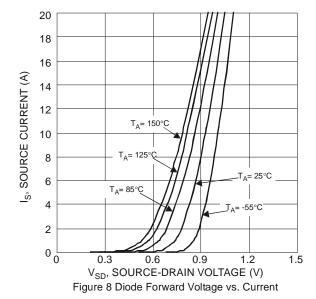
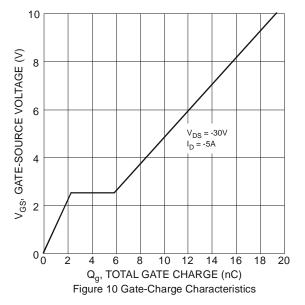


Figure 7 Gate Threshold Variation vs. Ambient Temperature

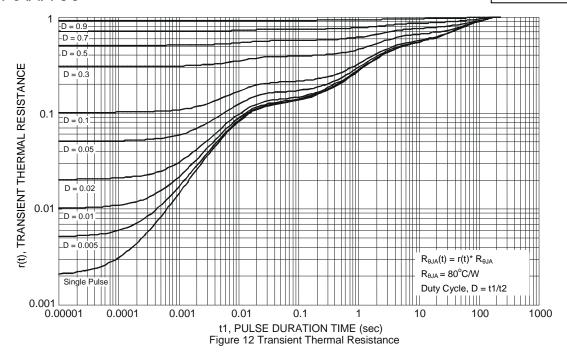






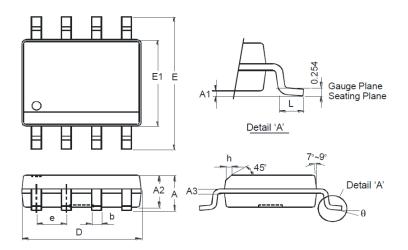






## **Package Outline Dimensions**

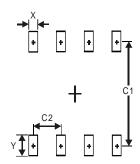
Please see http://www.diodes.com/package-outlines.html for the latest version.



SO-8					
Dim	Min	Max			
Α	-	1.75			
A1	0.10	0.20			
A2	1.30	1.50			
A3	0.15	0.25			
b	0.3	0.5			
D	4.85	4.95			
Е	5.90	6.10			
E1	3.85	3.95			
е	1.27 Typ				
h	-	0.35			
L	0.62	0.82			
θ	0°	8°			
All Dimensions in mm					

## **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.



Dimensions	Value (in mm)		
Х	0.60		
Y	1.55		
C1	5.4		
C2	1.27		



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